Application/Control No. Applicant(s)/Patent Under Reexamination 09/748,509 HAYASHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Kim-Kwok CHU 2653 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,584,053 06-2003 Tsukihashi, Akira 369/53.34 Α US-В С US-US-D US-Ε US-F US-G US-Н USl US-J Κ US-L US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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